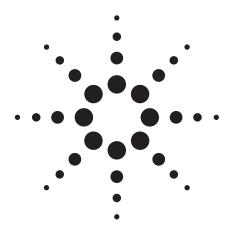
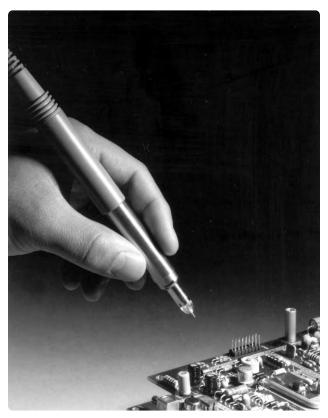
Agilent 85024A High Frequency Probe 300 kHz to 3 GHz

Product Overview



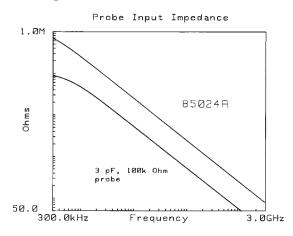


Excellent probing capability for demanding applications



Extend high frequency probing applications

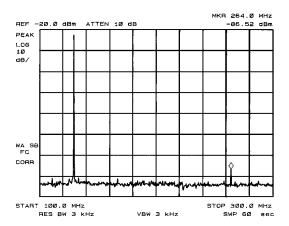
The Agilent Technologies 85024A high frequency probe offers excellent performance. The probe employs a GaAs IC to obtain extremely low input capacitance of only 0.7 pF shunted by 1 M Ω of resistance. Because of this low input capacitance, high frequency probing is possible without adversely loading the circuit under test. Also, the 1 M Ω shunt resistance guarantees minimal circuit loading at lower frequencies. Since the probe has excellent sensitivity, it is well-suited for use with analyzers offering exceptional dynamic range. The 85024A is an excellent accessory for high frequency test equipment, especially Agilent RF network or spectrum analyzers which supply probe power from the front panel.



Probe with less error due to higher input impedance. For example, in a 50 ohm system at 500 MHz, the 85024A presents 455 ohms which produces a 10% signal loss from loading effects, while a 3 pF, 100 k Ω probe presents 106 ohms causing a 32% signal loss.

Spectrum analysis

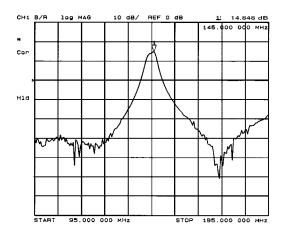
Troubleshooting RF and IF signal paths to identify problem areas in a system is convenient and accurate with an 85024A and a spectrum analyzer. Measurements of frequency, power, modulation, distortion, conversion loss, and spectral purity are possible within a circuit. High sensitivity and low distortion levels ensure the probe's ability to detect small signals or search for spurious responses. In fact, the sensitivity of most 85024A applications is limited only by the noise floor of the spectrum analyzer itself. Add a tracking generator to easily perform swept in-circuit measurements.



Troubleshoot IF paths for low level spurious responses.

Network analysis

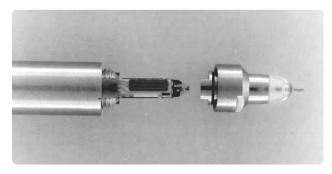
When used with a network analyzer, this versatile probe makes it easy to measure the gain, attenuation, phase linearity, or group delay of individual circuit stages. Also, investigate multi-stage circuits to rapidly determine the location of faults in a system. Low input capacitance and high shunt resistance minimizes the loading to the circuit under test. Excellent frequency response and unity gain of the Agilent 85024A guarantee high accuracy in swept measurements.



Excellent flatness maintains accuracy in swept measurements.

Advanced Design

Simplicity and reliability are inherent in the design of the 85024A. The front end was designed using a custom GaAs IC to provide low input capacitance. A retractable metal sleeve protects the probe from physical damage to the tip when not in use and, more importantly, from electrostatic discharge (ESD) damage to the probe. By retracting the metal sleeve, the user establishes himself at the same potential as the high frequency probe. Thus, it may be handled with less possibility of electrostatic damage. Finally, the entire probe front end is easily disassembled for quick replacement in the field.



A replaceable state-of-the-art GaAs IC provides high performance and extends the lifetime of the 85024A.

Compatible with Many Agilent Instruments

Direct compatibility with many RF analyzers further leverages the performance and flexibility of the 85024A high frequency probe. Spectrum analyzers that supply probe power from the front panel include the Agilent E444xA PSA Series high performance spectrum analyzers, E44xxB ESA Series portable spectrum analyzers, and 8560 Series, as well as the 8590 and 71100 Series. Network analyzers like the 4395, 871x, 875x, 872x, and PNA Series are also directly compatible. In addition, utilize the high frequency probe with other instruments by making use of an external probe power supply like the Agilent 11899A.

Specifications

(Terminated with 11880-60001 Type-N Adapter)

Specifications describe the warranted performance over the temperature range of 25° C $\pm 5^{\circ}$ C (except where noted). **Supplemental characteristics** are intended to provide information useful in applying the instrument by giving unwarranted performance parameters. These are denoted as "typical," "nominal," or "approximate."

 $\begin{array}{ll} \mbox{Input capacitance (at 500 MHz)} & <0.7 \mbox{pF (nominal)} \\ \mbox{Input resistance} & 1 \mbox{ } M\Omega \mbox{ (nominal)} \\ \end{array}$

Bandwidth 300 kHz to 3 GHz (nominal)

 $\begin{tabular}{lll} \mbox{Usable to 100 kHz} \\ \mbox{Average gain} & \mbox{0 dB} \pm 1.25 \mbox{ dB} \\ \end{tabular}$

Average gain is defined as the average of the maximum and minimum gains over the frequency range of 300 kHz to 1 GHz (maximum gain + minimum gain)/2.

Frequency response (relative to Average Gain):

Average noise level < 1 mV, 10 Hz to 10 MHz

Input voltage for < 1 dB compression 0.3 V

Supplemental Characteristics

Noise figure

Maximum safe input

Probe alone ± 1.5 V peak RF, ± 50 V DC Probe with 10:1 divider ± 15 V peak RF, ± 200 V DC

10:1 divider characteristics

 $\begin{array}{ll} \mbox{Input capacitance} & < 0.7 \ \mbox{pF} \\ \mbox{Input resistance} & 1 \ \mbox{M}\Omega \\ \mbox{Input voltage for 1 dB compression} & 3 \ \mbox{V} \end{array}$

Power

Supplied by certain Agilent instruments or

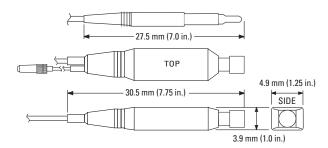
Agilent 11899A probe power supply +15 V/130 mA, -12.6 V/45 mA

 Weight
 Net 0.255 kg (0.563 lb),

 Shipping 1.49 kg (3.3 lb)

 Dimensions
 Probe assembly length

 1245 mm (49 in)



Other Accessories

11899A Probe power supply

10218A Probe to BNC male adapter

(recommended for use with the

8590 Series)

Accessories Furnished with the 85024A

11880-60001 Type-N male adapter

11881-60001 10:1 divider

01123-61302 2.5-inch ground lead 5060-0549 Spanner tip Assembly 8710-1806 Probe tip nut driver

10229A Hook tip

> 30 mil Spare probe tips 12 mil Spare probe tips





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